


<b>Search Notes</b>  	<b>Application/Control No.</b>  10571181	<b>Applicant(s)/Patent Under Reexamination</b>  VIEHMANN, MATTHIAS
	<b>Examiner</b>  DON WILLIAMS	<b>Art Unit</b>  2878

SEARCHED			
Class	Subclass	Date	Examiner
250	227.11, 227.14, 559.43, 208.4,426	7/26/2009	DW
361	45,87	7/26/2009	DW
324	96,11R	7/26/2009	DW
356	313	7/26/2009	DW
398	17,20	7/26/2009	DW
327	190	7/26/2009	DW
362	551	7/26/2009	DW
385	12,101,106	8/27/2009	DW

SEARCH NOTES		
Search Notes	Date	Examiner
US-PGPUB, USPAT, USOCR, JPO, EPO, DERWENT, IBM_TDB	7/26/2009	DW
PCT/EP04/10499 considered.	6/3/2008	DW
Consulted with Examiner Pyo of Class 250.	6/3/2008	DW
Consulted with Examiner Pyo of Class 250.	2/19/2009	DW
Consulted with Examiner Pyo of Class 250.	7/24/2009	DW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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